

Search Notes**Application/Control No.**

10/712,778

Examiner

Phi D. A

Applicant(s)/Patent under Reexamination

MEIJER ET AL.

Art Unit

3637

SEARCHED

Class	Subclass	Date	Examiner
52	716.8	5/10/2006	PA
403	403		
	382		
	286		
	293		
d25	55		
	61		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PA		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner